Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/621,881	LEE ET AL.	
Examiner	Art Unit	
Tai Duong	2871	

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Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST (US PGPUB, USPAT, EPO, JPO, DERWENT, IBM TDB) see search history printout	3/18/2006	TD	